infineon

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

CoolMOS™ CE

800V CoolMOS™ CE Power Transistor
IPx80R1K4CE

Data Sheet

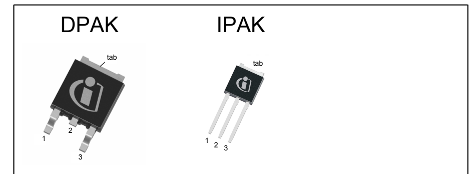
Rev. 2.2
Final

Power Management & Multimarket

Downloaded From Oneyac.com

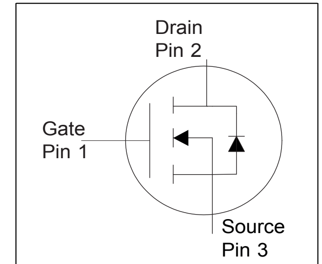
1 Description

CoolMOS™ CE is a revolutionary technology for high voltage power MOSFETs. The high voltage capability combines safety with performance and ruggedness to allow stable designs at highest efficiency level. CoolMOS™ 800V CE comes with a selected package choice offering the benefit of reduced system costs and higher power density designs.



Features [1)]

- High voltage technology
- Extreme dv/dt rated
- High peak current capability
- Low gate charge
- Low effective capacitances
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)
- Pb-free lead plating; RoHS compliant; halogen free mold compound



Benefits

- Increased power density solutions due to smaller package
- System cost / size savings due to reduced cooling requirements
- Higher system reliability due to low operating temperatures

Applications

- LED Lighting for retrofit applications in QR Flyback topology

Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS} @ $T_{j=25°C}$	800	V
$R_{DS(on),max}$	1.4	Ω
$Q_{g,typ}$	23	nC
$I_{D,pulse}$	12	A
$V_{GS(th),typ}$	3	V
$C_{O(tr),typ}$	51	pF

Type / Ordering Code	Package	Marking	Related Links
IPD80R1K4CE	PG-TO 252	8R1K4CE	see Appendix A
IPU80R1K4CE	PG-TO 251		

Downloaded From Oneyac.com

Table of Contents

Description 2
Maximum ratings 4
Thermal characteristics 4
Electrical characteristics 5
Electrical characteristics diagrams 7
Test Circuits 11
Package Outlines 12
Appendix A 14
Revision History 15
Disclaimer 15

Downloaded From Oneyac.com

2 Maximum ratings

at T_j = 25°C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current [1]	I_D	- -	- -	3.9 2.3	A	T_C = 25°C T_C = 100°C
Pulsed drain current [2]	$I_{D,pulse}$	-	-	12	A	T_C=25°C
Avalanche energy, single pulse	E_{AS}	-	-	170	mJ	I_D =1.2A; V_{DD} = 50V
Avalanche energy, repetitive	E_{AR}	-	-	0.14	mJ	I_D =1.2A; V_{DD} = 50V
Avalanche current, repetitive	I_{AR}	-	-	1.2	A	-
MOSFET dv/dt ruggedness	dv/dt	-	-	50	V/ns	V_{DS} =0...640V
Gate source voltage	V_{GS}	-20 -30	- -	20 30	V	static; AC (f>1 Hz)
Power dissipation (non FullPAK) TO-252, TO-251	P_{tot}	-	-	63	W	T_C = 25°C
Operating and storage temperature	T_j, T_{stg}	-55	-	150	°C	-
Continuous diode forward current	I_S	-	-	3.9	A	T_C = 25°C
Diode pulse current[2]	$I_{S,pulse}$	-	-	12	A	T_C = 25°C
Reverse diode dv/dt [3]	dv/dt	-	-	4	V/ns	V_{DS} =0...400V, $I_{SD} \leq I_S$, T_j=25°C
Maximum diode commutation speed	di_f/dt	-	-	400	A/µs	V_{DS} =0...400V, $I_{SD} \leq I_S$, T_j=25°C

3 Thermal characteristics

Table 3 Thermal characteristics DPAK, IPAK

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	2	°C/W	-
Thermal resistance, junction - ambient [4]	R_{thJA}	- -	- 35	62 -	°C/W	SMD version, device on PCB, minimal footprint SMD version, device on PCB, 6cm² cooling area[4]
Soldering temperature, wave- & reflowsoldering allowed	T_{sold}	-	-	260	°C	reflow MSL 1

[1] Limited by $T_{j\,max}$.
[2] Pulse width t_p limited by $T_{j,max}$
[3] Identical low side and high side switch with identical R_G
[4] Device on 40mm*40mm*1.5mm one layer epoxy PCB FR4 with 6cm² copper area (thickness 70µm) for drain connection. PCB is vertical without air stream cooling.

Downloaded From Oneyac.com

4 Electrical characteristics

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	800	-	-	V	V_{GS}=0V, I_D=0.25mA
Gate threshold voltage	$V_{(GS)th}$	2.1	3	3.9	V	V_{DS}=V_{GS}, I_D=0.24mA
Zero gate voltage drain current	I_{DSS}	- -	- 50	10 -	µA	V_{DS}=800V, V_{GS}=0V, T_j=25°C V_{DS}=800V, V_{GS}=0V, T_j=150°C
Gate-source leakage curent	I_{GSS}	-	-	100	nA	V_{GS}=20V, V_{DS}=0V
Drain-source on-state resistance	$R_{DS(on)}$	- -	1.2 3.2	1.4 -	Ω	V_{GS}=10V, I_D=2.3A, T_j=25°C V_{GS}=10V, I_D=2.3A, T_j=150°C
Gate resistance	R_G	-	1.2	-	Ω	f=1 MHz, open drain

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	570	-	pF	V_{GS}=0V, V_{DS}=100V, f=1MHz
Output capacitance	C_{oss}	-	25	-	pF	V_{GS}=0V, V_{DS}=100V, f=1MHz
Effective output capacitance, energy related [1]	$C_{o(er)}$	-	19	-	pF	V_{GS}=0V, V_{DS}=0...480V
Effective output capacitance, time related [2]	$C_{o(tr)}$	-	51	-	pF	I_D=constant, V_{GS}=0V, V_{DS}=0...480V
Turn-on delay time	$t_{d(on)}$	-	25	-	ns	V_{DD}=400V, V_{GS}=0/10V, I_D=3.9A, R_G=22Ω
Rise time	t_r	-	15	-	ns	V_{DD}=400V, V_{GS}=0/10V, I_D=3.9A, R_G=22Ω
Turn-off delay time	$t_{d(off)}$	-	72	-	ns	V_{DD}=400V, V_{GS}=0/10V, I_D=3.9A, R_G=22Ω
Fall time	t_f	-	12	-	ns	V_{DD}=400V, V_{GS}=10 V, I_D=3.9A, R_G=22Ω

Table 6 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	3	-	nC	V_{DD}=640V, I_D=3.9A, V_{GS}=0 to 10V
Gate to drain charge	Q_{gd}	-	12	-	nC	V_{DD}=640V, I_D=3.9A, V_{GS}=0 to 10V
Gate charge total	Q_g	-	23	-	nC	V_{DD}=640V, I_D=3.9A, V_{GS}=0 to 10V
Gate plateau voltage	$V_{plateau}$	-	5.5	-	V	V_{DD}=640V, I_D=3.9A, V_{GS}=0 to 10V

[1] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$
[2] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$

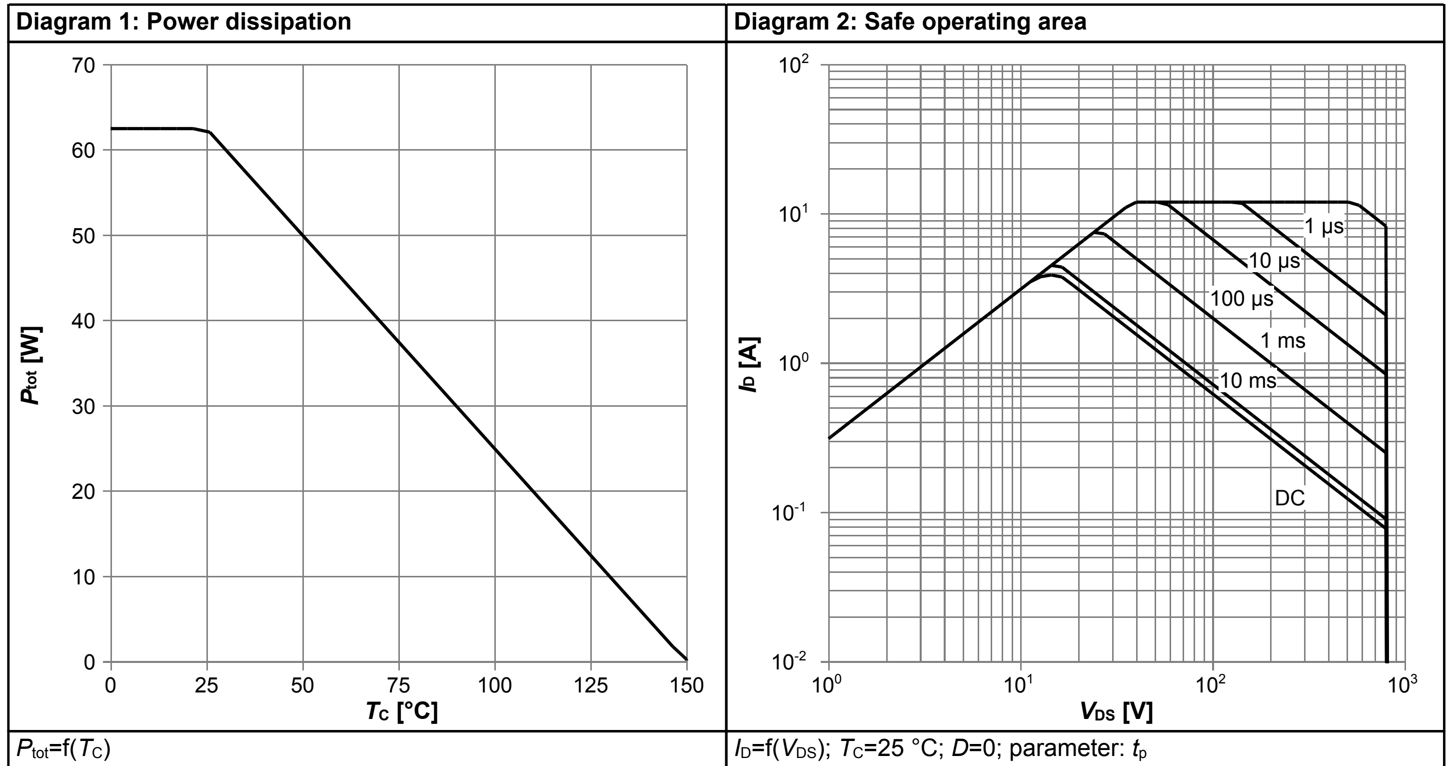
Downloaded From Oneyac.com

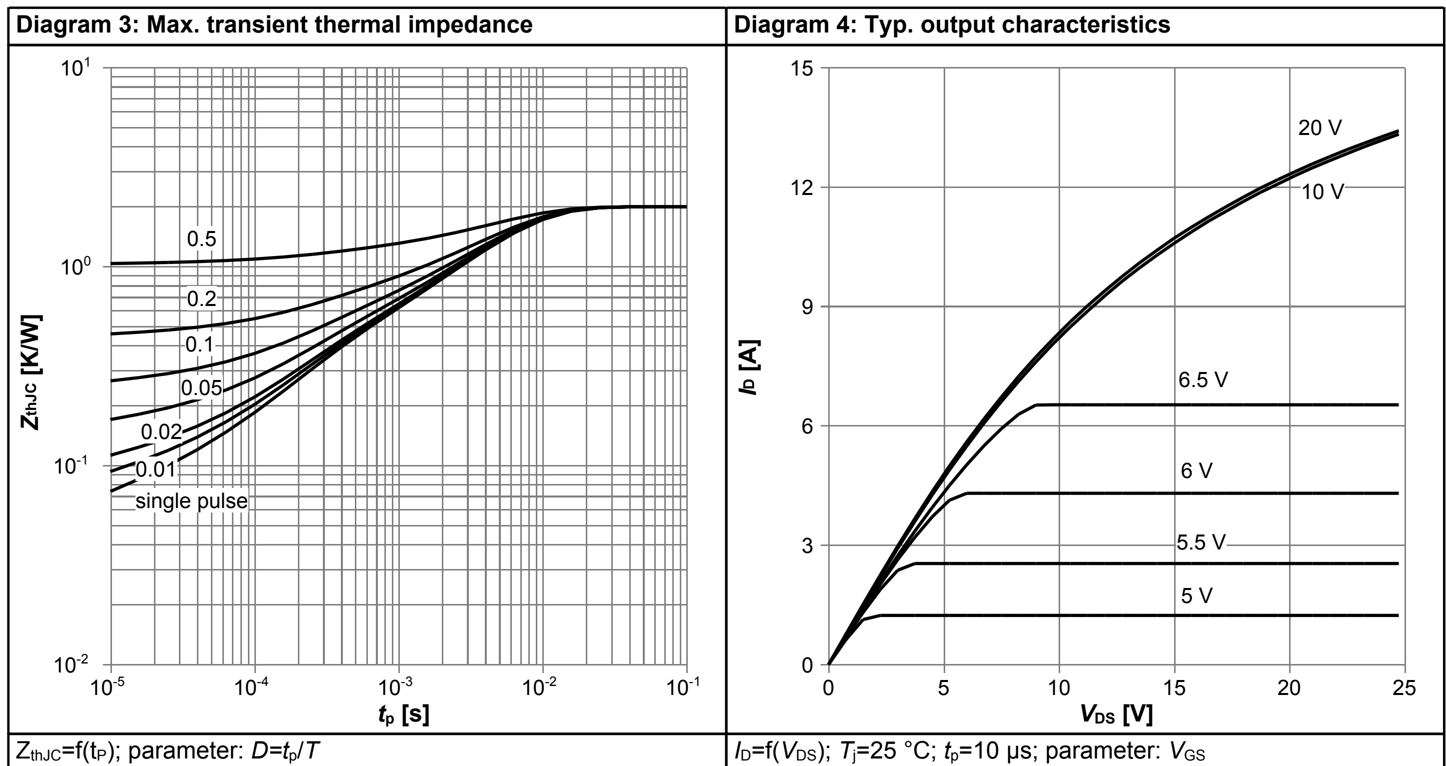
Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	-	1	1.2	V	V_{GS}=0V, I_F=3.9A, T_j=25°C
Reverse recovery time	t_{rr}	-	520	-	ns	V_R=400V, I_F=3.9A, di_F/dt=100A/µs
Reverse recovery charge	Q_{rr}	-	4	-	µC	V_R=400V, I_F=3.9A, di_F/dt=100A/µs
Peak reverse recovery current	I_{rrm}	-	12	-	A	V_R=400V, I_F=3.9A, di_F/dt=100A/µs

Downloaded From Oneyac.com

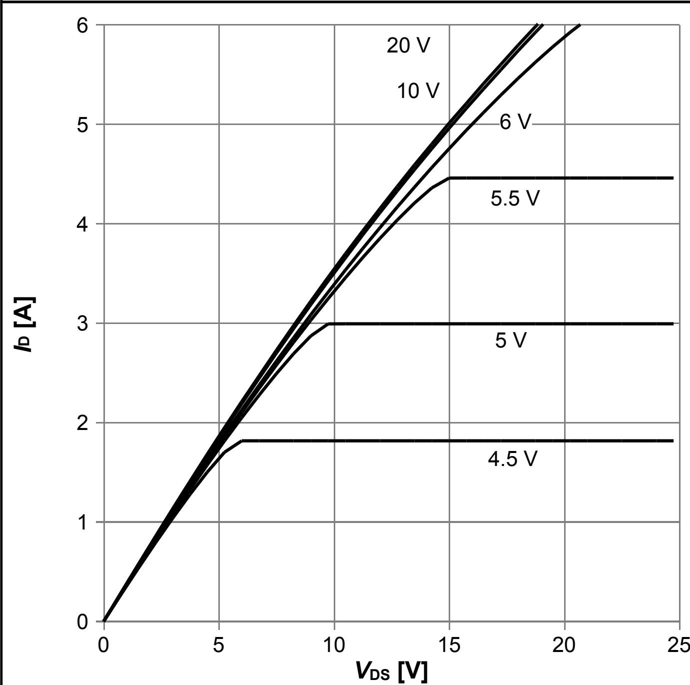
5 Electrical characteristics diagrams





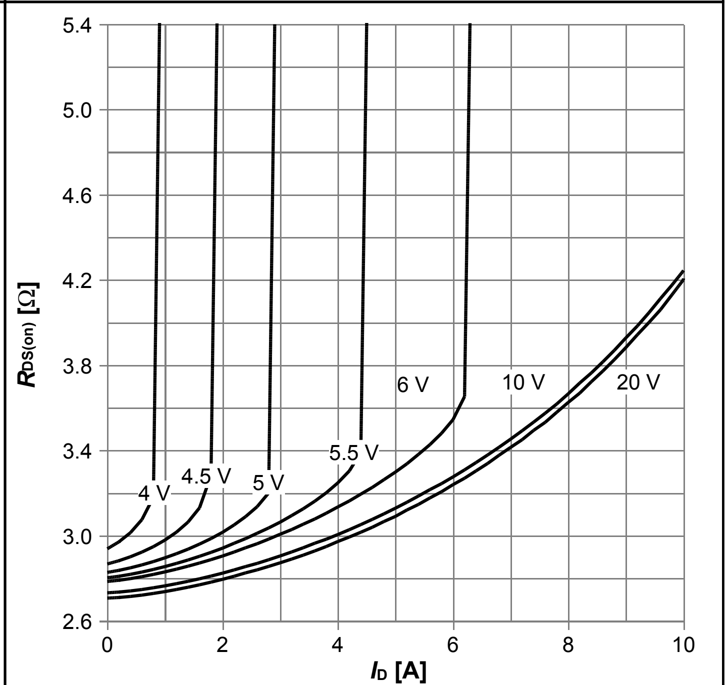
Downloaded From Oneyac.com

Diagram 5: Typ. output characteristics



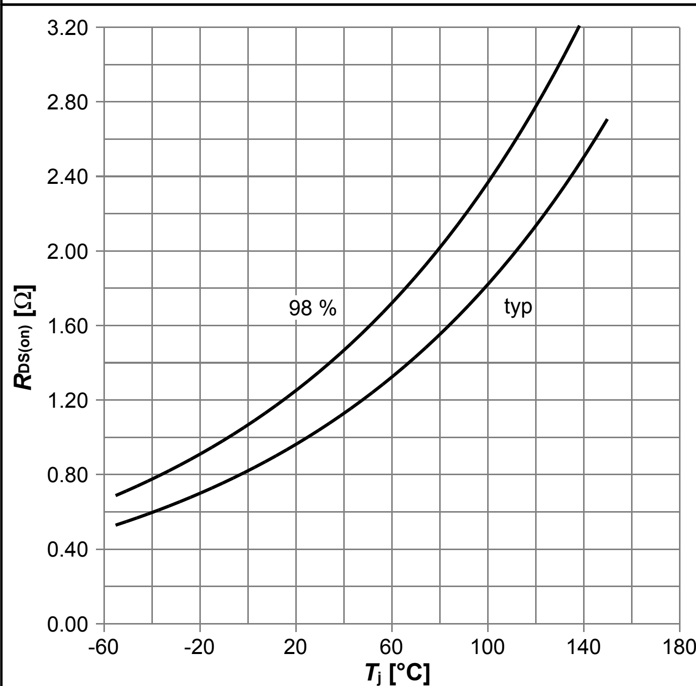
I_D=f(V_{DS}); T_j=150 °C; t_p=10 µs; parameter: V_{GS}

Diagram 6: Typ. drain-source on-state resistance



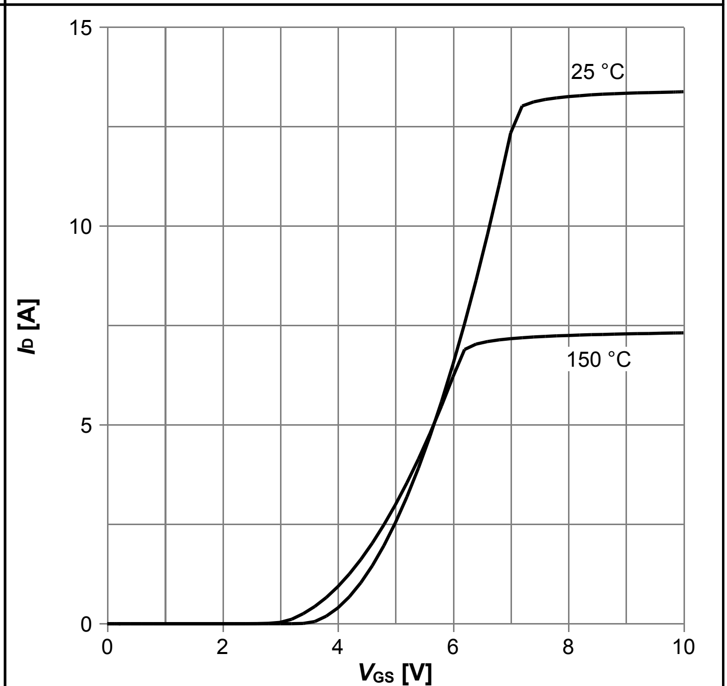
$R_{DS(on)}$=f(I_D); T_j=150 °C; parameter: V_{GS}

Diagram 7: Drain-source on-state resistance



$R_{DS(on)}$=f(T_j); I_D=2.3 A; V_{GS}=10 V

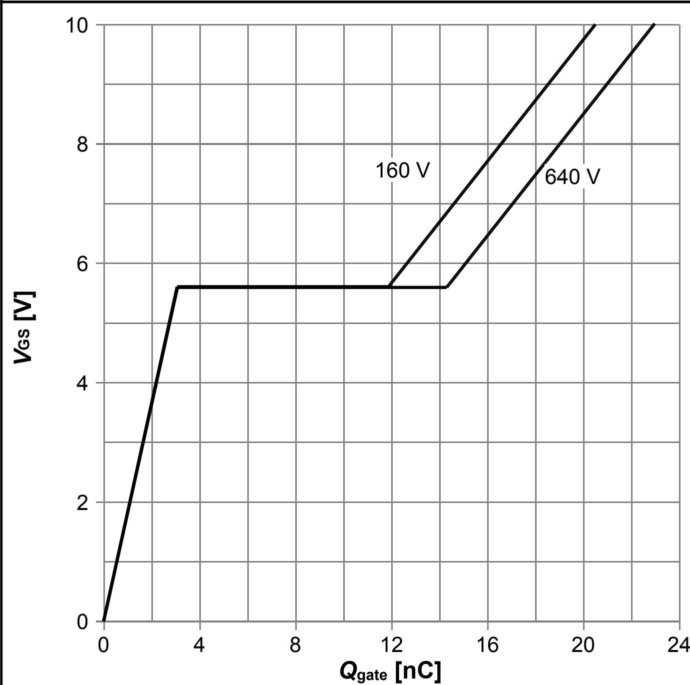
Diagram 8: Typ. transfer characteristics



I_D=f(V_{GS}); |V_{DS}|>2|I_D|$R_{DS(on)max}$; t_p=10 µs; parameter: T_j

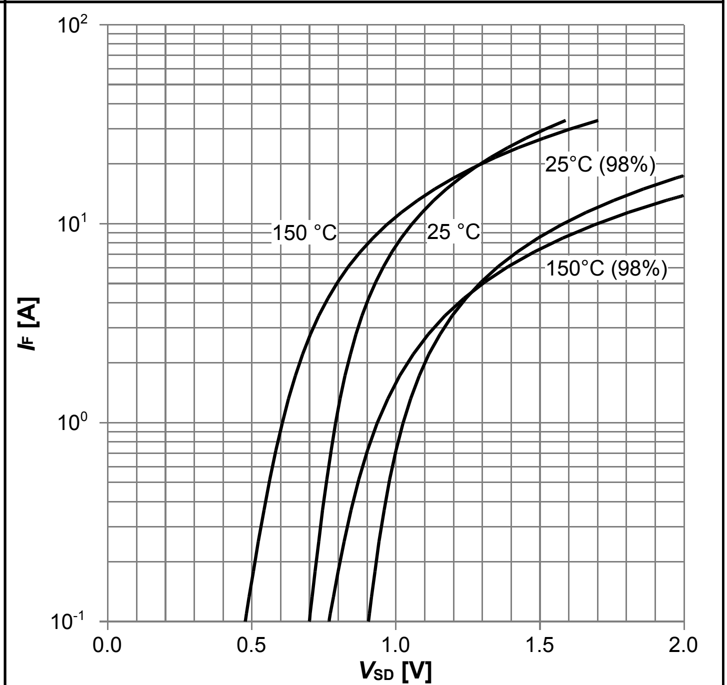
Downloaded From Oneyac.com

Diagram 9: Typ. gate charge



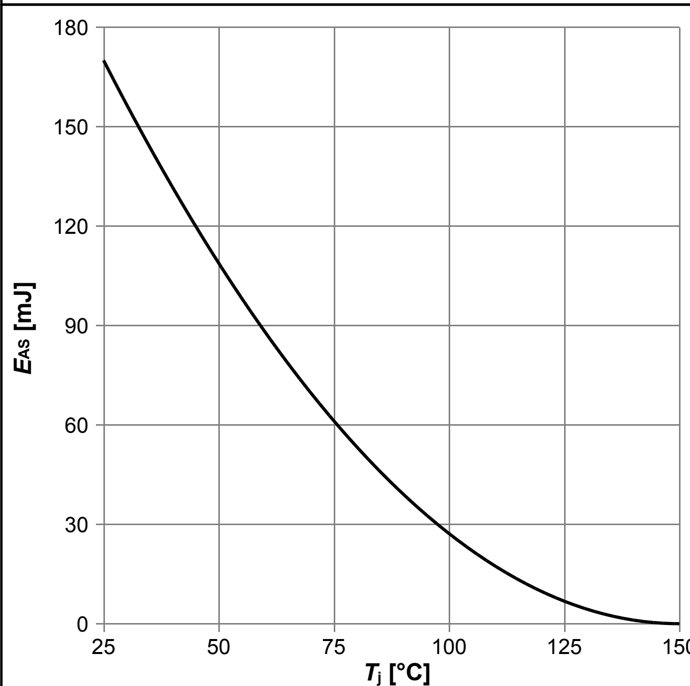
V_{GS}=f(Q_{gate}); I_D=3.9 A pulsed; parameter: V_{DD}

Diagram 10: Forward characteristics of reverse diode



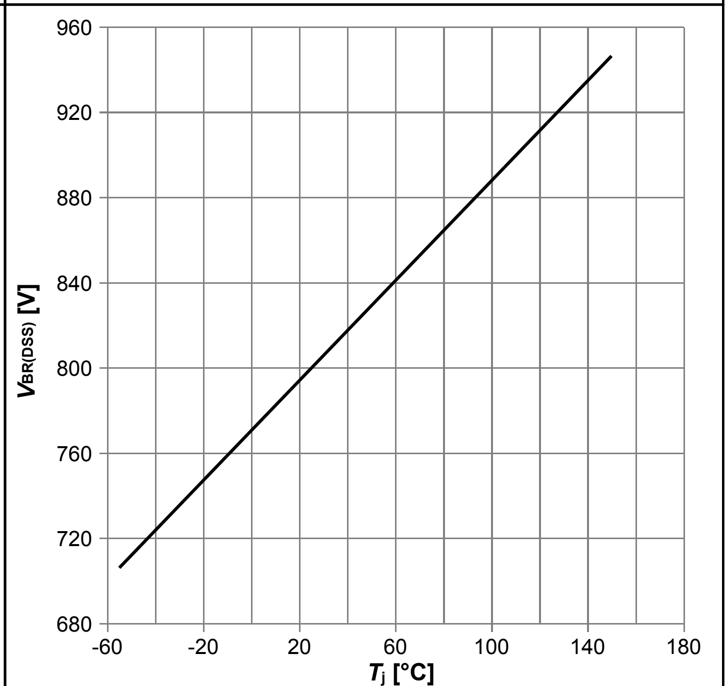
I_F=f(V_{SD}); t_p=10 µs; parameter: T_j

Diagram 11: Avalanche energy



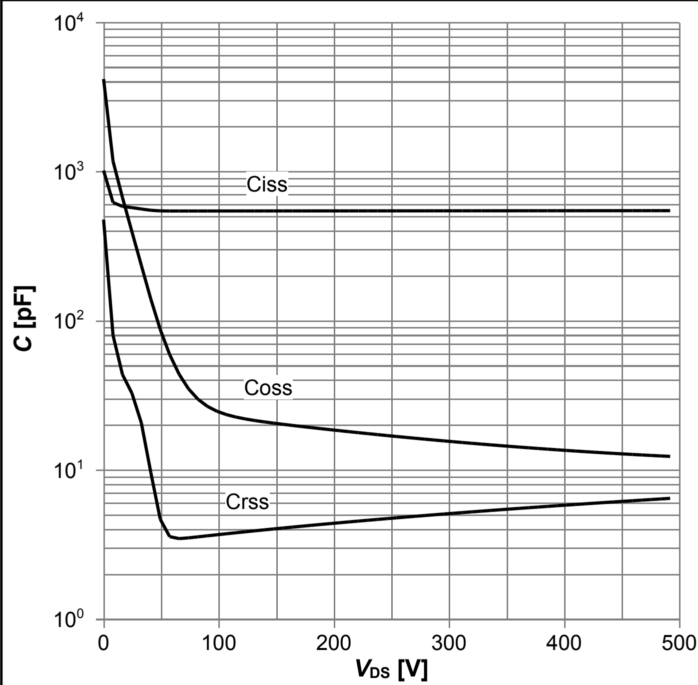
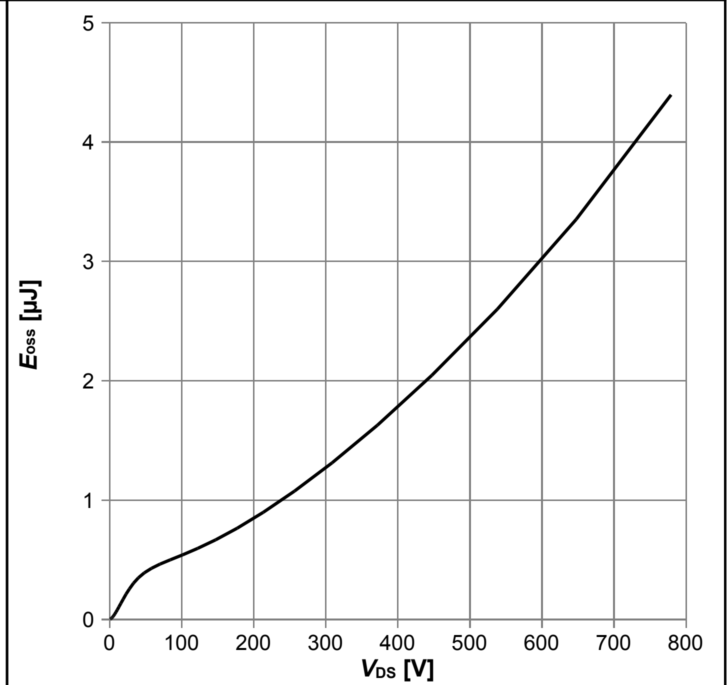
E_{AS}=f(T_j); I_D=1.2 A; V_{DD}=50 V

Diagram 12: Drain-source breakdown voltage



$V_{BR(DSS)}$=f(T_j); I_D=0.25 mA

Downloaded From Oneyac.com

Diagram 13: Typ. capacitances	Diagram 14: Typ. Coss stored energy
	
C=f(V_{DS}); V_{GS}=0 V; f=1 MHz	E_{oss}=f(V_{DS})

Downloaded From Oneyac.com

6 Test Circuits

Table 8 Diode characteristics

Test circuit for diode characteristics	Diode recovery waveform
$R_g1 = R_g2$	$t_{rr} = t_F + t_S$ $Q_{rr} = Q_F + Q_S$

Table 9 Switching times

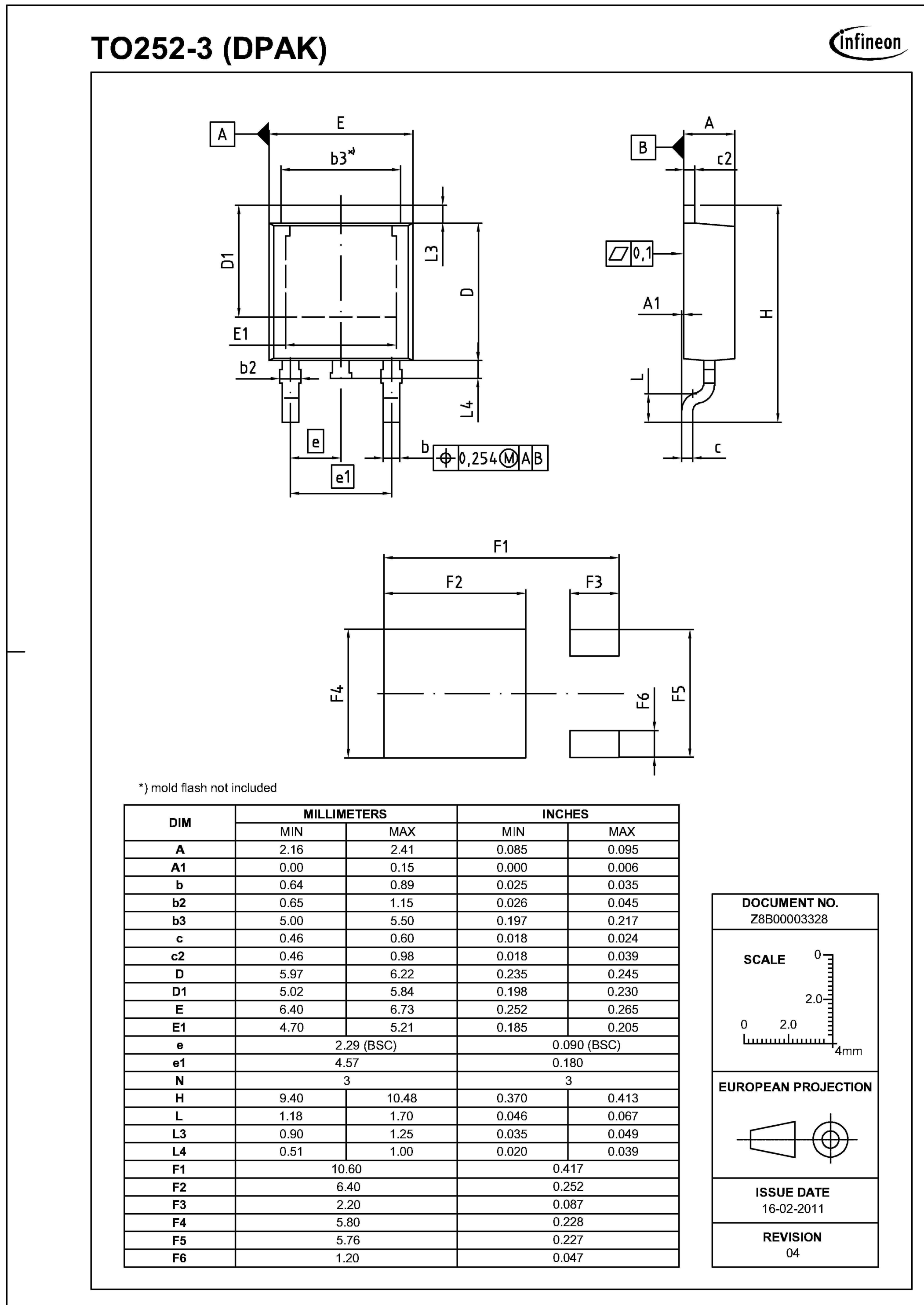
Switching times test circuit for inductive load	Switching times waveform

Table 10 Unclamped inductive load

Unclamped inductive load test circuit	Unclamped inductive waveform

Downloaded From Oneyac.com

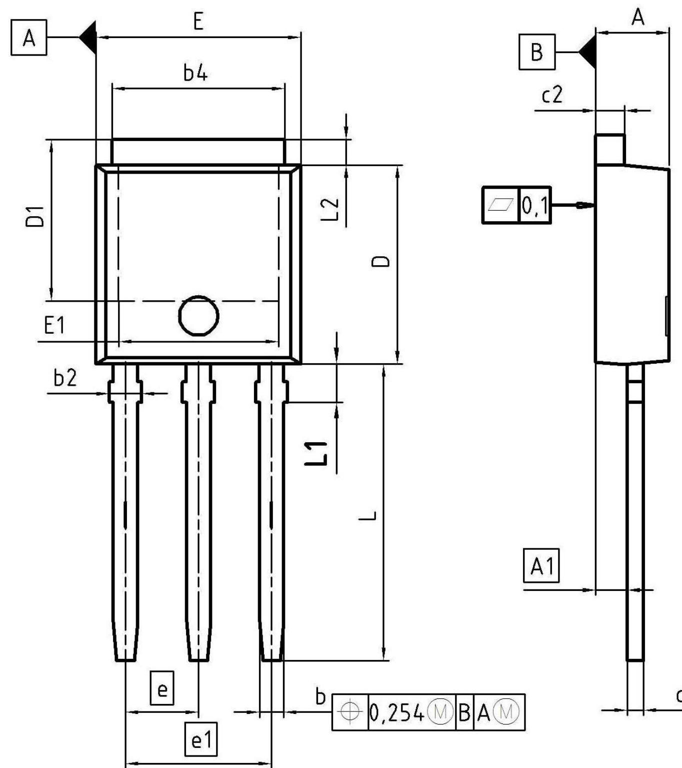
7 Package Outlines



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.16	2.41	0.085	0.095
A1	0.00	0.15	0.000	0.006
b	0.64	0.89	0.025	0.035
b2	0.65	1.15	0.026	0.045
b3	5.00	5.50	0.197	0.217
c	0.46	0.60	0.018	0.024
c2	0.46	0.98	0.018	0.039
D	5.97	6.22	0.235	0.245
D1	5.02	5.84	0.198	0.230
E	6.40	6.73	0.252	0.265
E1	4.70	5.21	0.185	0.205
e	2.29 (BSC)		0.090 (BSC)	
e1	4.57		0.180	
N	3		3	
H	9.40	10.48	0.370	0.413
L	1.18	1.70	0.046	0.067
L3	0.90	1.25	0.035	0.049
L4	0.51	1.00	0.020	0.039
F1	10.60		0.417	
F2	6.40		0.252	
F3	2.20		0.087	
F4	5.80		0.228	
F5	5.76		0.227	
F6	1.20		0.047	

Figure 1 Outline PG-TO 252, dimensions in mm/inches

Downloaded From Oneyac.com



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.16	2.41	0.085	0.095
A1	0.90	1.14	0.035	0.045
b	0.64	0.89	0.025	0.035
b2	0.65	1.15	0.026	0.045
b4	4.95	5.50	0.195	0.217
c	0.46	0.60	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.04	5.77	0.198	0.227
E	6.35	6.73	0.250	0.265
E1	4.70	5.21	0.185	0.205
e	2.29		0.090	
e1	4.57		0.180	
N	3		3	
L	8.89	9.65	0.350	0.380
L1	1.90	2.29	0.075	0.090
L2	0.89	1.37	0.035	0.054

DOCUMENT NO.
Z8B00003330

SCALE 0 2.0 0 2.0 4mm

EUROPEAN PROJECTION

ISSUE DATE
19-03-2008

REVISION
03

Figure 2 Outline PG-TO 251, dimensions in mm/inches

Downloaded From Oneyac.com

8 Appendix A

Table 11 Related Links

- **IFX CoolMOS Webpage:** www.infineon.com
- **IFX Design tools:** www.infineon.com

Downloaded From Oneyac.com

Revision History

IPx80R1K4CE

Revision: 2016-04-27, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2013-06-24	Release of final version
2.1	2013-07-18	updtae to halogen free mold compound
2.2	2016-04-27	Non-halogen free version discontinued

Trademarks of Infineon Technologies AG

AURIX™, C166™, CanPAK™, CIPOS™, CoolGaN™, CoolMOS™, CoolSET™, CoolSiC™, CORECONTROL™, CROSSAVE™, DAVE™, DI-POL™, DrBlade™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPACK™, EconoPIM™, EiceDRIVER™, eupec™, FCOS™, HITFET™, HybridPACK™, Infineon™, ISOFACE™, IsoPACK™, i-Wafer™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OmniTune™, OPTIGA™, OptiMOS™, ORIGA™, POWERCODE™, PRIMARION™, PrimePACK™, PrimeSTACK™, PROFET™, PRO-SIL™, RASIC™, REAL3™, ReverSave™, SatRIC™, SIEGET™, SIPMOS™, SmartLEWIS™, SOLID FLASH™, SPOC™, TEMPFET™, thinQ!™, TRENCHSTOP™, TriCore™.

Trademarks updated August 2015

Other Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

We Listen to Your Comments
Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to:
erratum@infineon.com

Published by
Infineon Technologies AG
81726 München, Germany
© 2016 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer
The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information
For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (**www.infineon.com**).

Warnings
Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.
The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

Downloaded From Oneyac.com

ONEYAC 唯样商城 电子元器件线上授权代理开拓者 原厂授权·正品现货·一件即发

单击下面可查看定价，库存，交付和生命周期等信息

>>Infineon Technologies(英飞凌)

>>点击查看相关商品

Downloaded From Oneyac.com